

5/8/17

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PV Monitoring and Modeling

a machine learning perspective

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*Exceptional
service
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Overview

Introduction

What is Machine Learning?

Why use Machine Learning?

How can Machine Learning Provide Value?

Data Monitoring Quality

Rule-based versus Outlier Detection

Performance Validation

... Based on Extensive Data Sets

... Based on Limited Data Sets

Fault Detection & Diagnostics (FDD)

Novelty Detection

Multi-Class Classification

What is Machine Learning?

What?

Machine Learning is the science of programming a computer so that they can learn from data

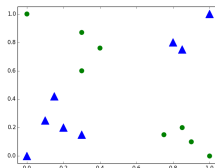
Two main types:

1. Supervised learning:
Inputs w/ desired outputs
2. Unsupervised learning:
Inputs w/out desired outputs

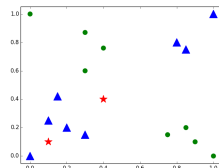
Supervised Learning Example

Classification using Support Vector Machine

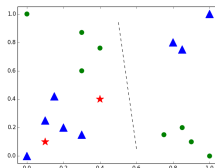
XOR data



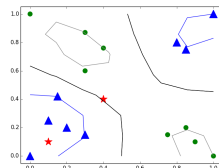
Classify new data



Not linearly separable



Non-linear classification



Why use Machine Learning?

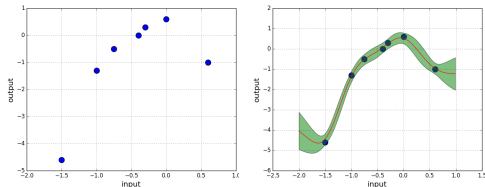
Why?

1. Regression
2. Classification
3. Density estimation
4. Others

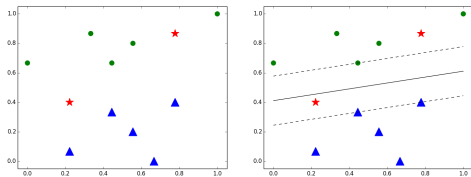
Approaches:

1. Artificial Neural Networks
2. Deep Learning
3. Support Vector Machines
4. Clustering
5. Many others

Regression (Gaussian Process)



Classification (Support Vector Machine)



How can Machine Learning Provide Value?

Design

1. Specify system
2. Estimate production
3. Confirm budget/financing

Build

1. System matches design
2. Correct Equipment/Connections
3. Reliable data monitoring

Operate

1. Monitor
2. Validate performance
3. Identify faults

Model Types:

1. SAPM
2. Single Diode
3. Others

Model Types:

1. N/A

Model Types:

1. Model-based
2. Model and ML
3. ML

Machine Learning Applications?

Data Monitoring Quality:

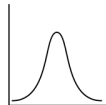
Rule-based

```

if True then
  Report
else
  No Report
end if

```

Outlier Detection



Validate Performance:

Extensive Data

Inputs = $\{E, T_{module}\}$

Outputs = $\{\text{Power}\}$

Limited Data

InputsA = $\{P_{nearby}\}$

InputsB = $\{E_{forecast}\}$

Outputs = $\{\text{Power}\}$

Fault Analysis:

Fault Detection

Anomaly/Novelty

Detection

Fault Diagnostics

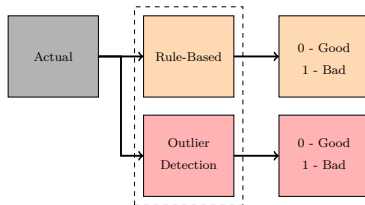
Multi-Class Classification

Data Monitoring: Rule-Based versus Outlier Detection

Problem Statement

Machine learning can use polluted data that contains incorrect or corrupt data records to identify outliers by assuming a distribution.

Process



Results

Rule-Based

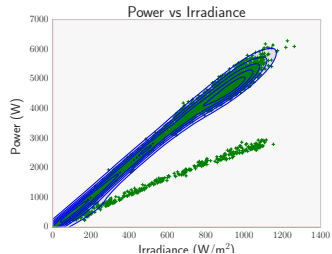
Rules were not violated

```

if Power > Pmpp × Numbermod. × 1.2 = 7776
then
  Alarm
else if Power < 0 then
  Alarm
end if
  
```

Kernel Density Function

Outliers were detected

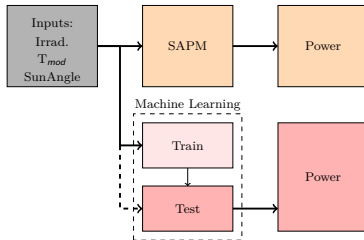


Validate Performance: Extensive Data

Problem Statement

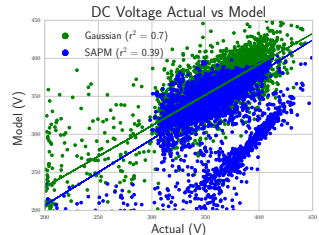
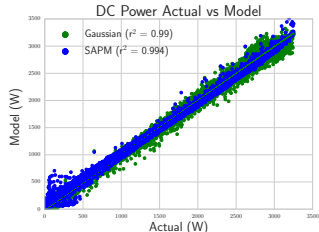
Machine learning can model existing PV systems using collected weather and performance data.

Process



Train: 01/16 to 12/16 -> Test: 01/17 to 04/17

Results

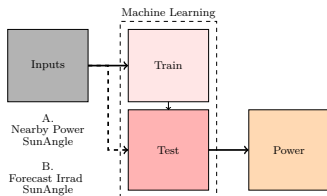


Validate Performance: Limited Data

Problem Statement

Machine learning can model existing PV systems where power is the only monitored value. The algorithm can associate PV power with nearby system outputs and forecasted irradiance.

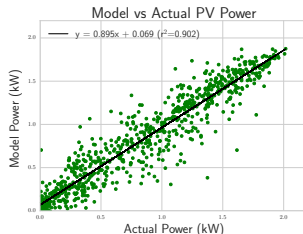
Process



Results

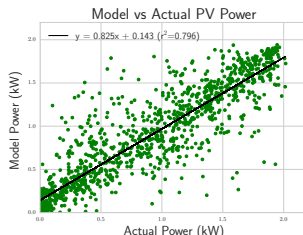
Inputs A:

1. Nearby Power (17km)
2. Sun Angle



Inputs B:

1. Forecast Irrad. (NOAA)
2. Sun Angle



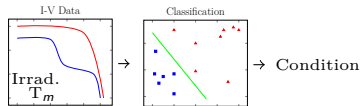
FDD: Novelty Detection (I-V Data)

Problem Statement

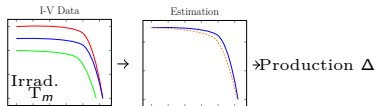
Machine learning can be used to perform binary classification of I-V curve data.

Process

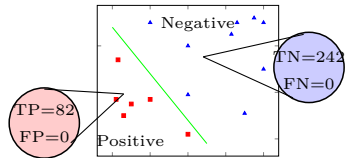
Classification



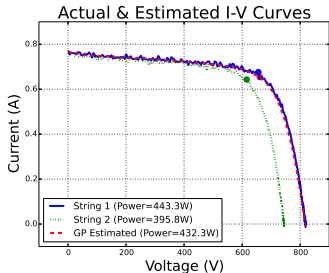
Estimation



Classification



Estimate Loss

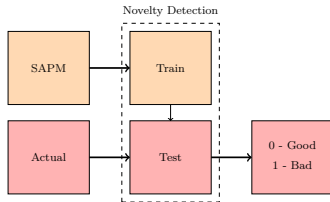


FDD: Novelty Detection (Max Power Point Data)

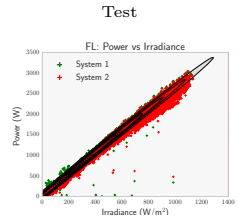
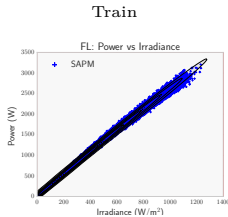
Problem Statement

Machine learning can be used to identify anomalies automatically by training on “clean” data and testing on new, possibly polluted, observations.

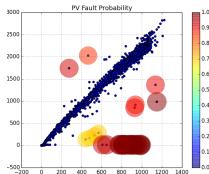
Process



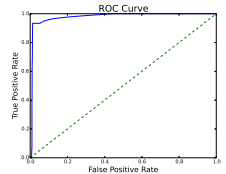
Train & Test Results



Estimate Probabilities



Evaluate Accuracy

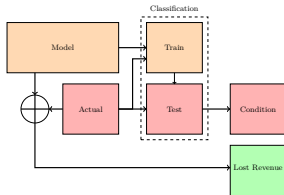


FDD: Classification (Max Power Point Data)

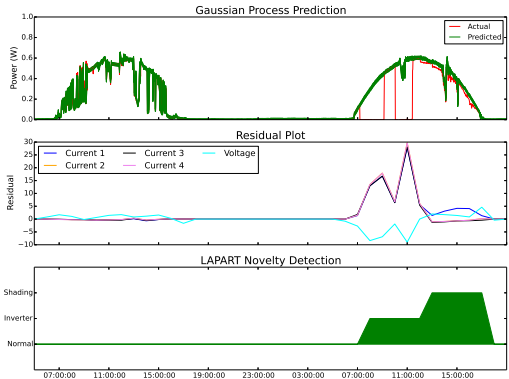
Problem Statement

Machine learning can be used to classify fault conditions and estimate lost revenue.

Process



Results



Machine Learning

1. What?
 - 1.1 machines can learn
 - 1.2 two main types of learning
2. Why?
 - 2.1 Regression
 - 2.2 Classification
3. How?
 - 3.1 Monitor
 - 3.2 Validation
 - 3.3 Faults

Examples

1. Data Quality
 - 1.1 Outlier Detection
provides detailed review
of collected data sets
2. Performance Validation
 - 2.1 ML can model PV
power, current, and
voltage given various
inputs
3. Fault Detection
 - 3.1 Classify I-V curve and
MPP data

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